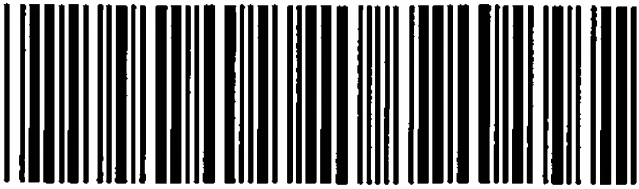


Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/613,768	MCKINLAY ET AL.	
	Examiner	Art Unit	
	J. Derek Rutten	2192	

SEARCHED			
Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Eric Kiss (consulted re. 112 and prior art)	10/13/2006	JDR
EAST (US-PGPUB; USPAT; EPO; JPO; IBM_TDB; DERWENT) - see search history printout	10/13/2006	JDR
717/178 Text search only See search history printout	10/13/2006	JDR